


<b>Search Notes</b> 	<b>Application/Control No.</b> 10774101	<b>Applicant(s)/Patent Under Reexamination</b> TSAI ET AL.
	<b>Examiner</b> Nguyen, Jennifer T	<b>Art Unit</b> 2629

SEARCHED			
Class	Subclass	Date	Examiner
345	87,98,100,204	3/16/07	JN

SEARCH NOTES		
Search Notes	Date	Examiner
east search, iEEE, JPO	3/16/07	JN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner